

Atty. Docket No. 1215.003

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant: Shingo Saito

Serial No.: 10/561,280 Group Art Unit: 2886

Filed: 03/19/2007 Examiner: Nguyen, Tu T.

Title: Optical Waveform Measurement Device and Measurement Method thereof,
Complex Refractive Index Measurement Device and Measurement Method Thereof, and
Computer Program Recording Medium Containing the Program

To: Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

RESPONSE AND AMENDMENT UNDER 37 CFR §1.121

Dear Sir or Madam:

This paper is filed in response to the Office Action mailed October 1, 2009. With the attached request for a one month extension, a response is due by February 1, 2010. This response is being filed on or before February 1, 2010, and is therefore timely filed.

Amendments

Please amend the above-identified U.S. application as follows: